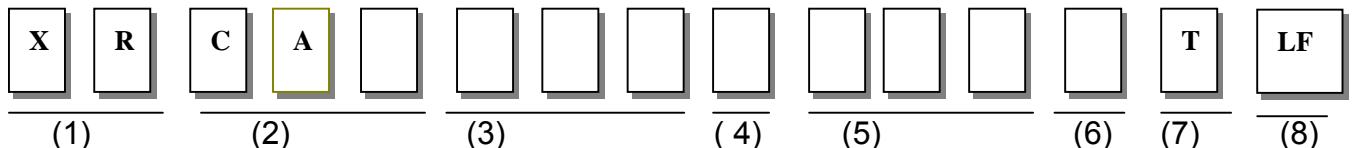


1. Scope

This specification applies to the _____ solid electrolyte tantalum chip capacitor(lead free).

2. Product Identification



Note:

- (1) company logo
- (2) series: For type recognition, series is expressed by three digits, that is: the first letters CA represent tantalum capacitors, 3rd digit represent series No., in case of no 3rd digit for specific product series, it is expressed by symbol“-”.
- (3) capacitance code: Capacitance code: expressed in Pico farad , 1st two digits represent significant figures and 3rd digit represents multiplier(number of zeros to follow)
- (4) capacitance tolerance: Capacitance tolerance code is listed as follows:

Allowable Tolerance Code of the Capacitance

Allowable Tolerance%	Tolerance Code
±5	J
±10	K
±20	M

(5) rated DC voltage: Rated DC voltage Code is expressed in three digits.

- (6) case size: Case Code is specified in specification sheets of the individual product series.
- (7) packing style(B: Bulk ; T: tape & reel):Packaging Code :B-Bulk.
T: Tape and Reel.A: Ammo.

EX: Series CA45Δc/c±20%, 35V10μF, Taped and Reeled, XRCA45106M350DT

Series CAΔc/c±20%, 10V10μF, Bulk, XRCA-106M1002B

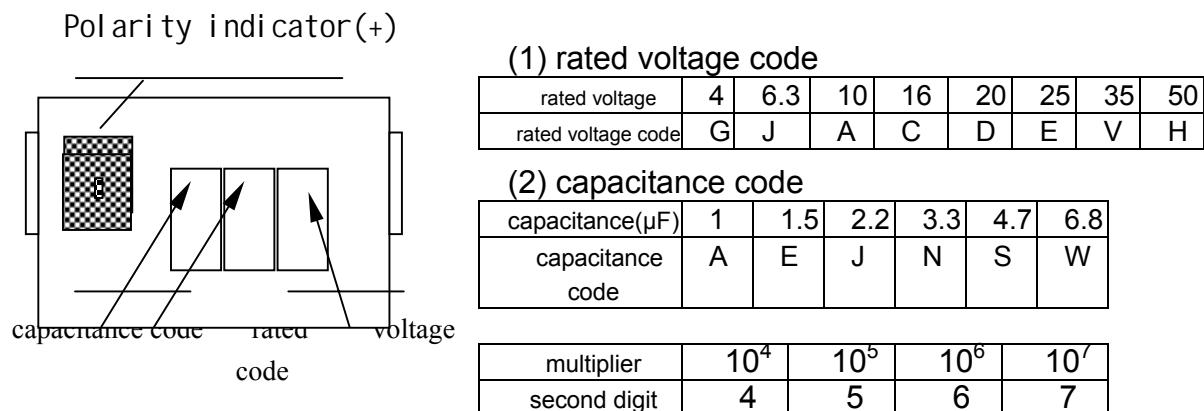
Series CA301Δc/c±20%, 100V10μF, Bulk, XRCA301106M1011B

For special order, other part number can be specified by users.

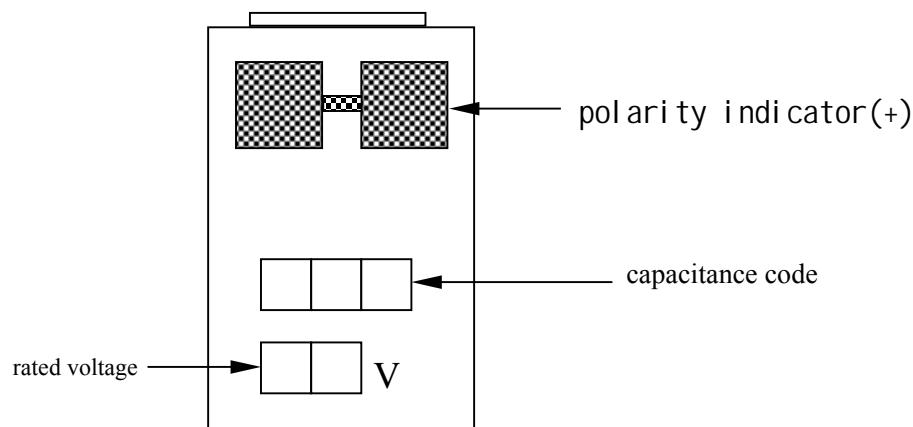
- (8) Lead Free

3. Marking

3.1 CA45(S&A case)

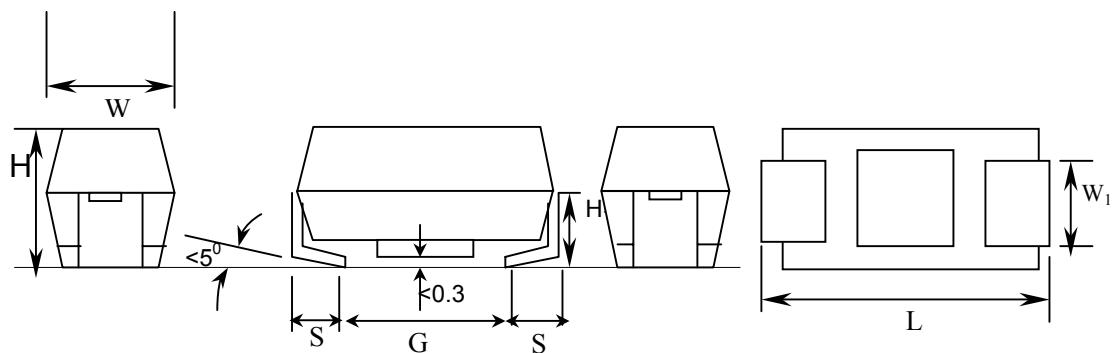


3.2 CA45(B,C,D&E case)



capacitance code: Capacitance designation is used in PF, the first two digits represent valid digits of capacitance, third digit represents number of zero to follow.

4. Outline & Dimensions



Solid Electrolytic Tantalum Chip Capacitor(Lead Free)
CA45 specification

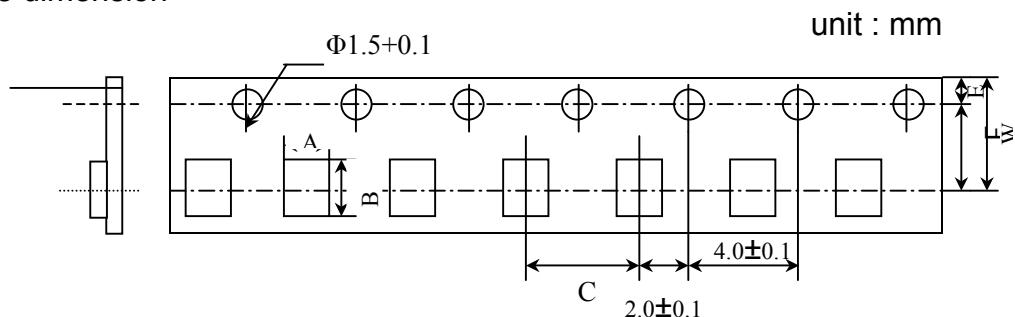
KOME

unit :mm

Case size	L	W	H	W ₁	S	H ₁ min	G min.
S	2.0±0.2	1.3±0.2	1.2Max.	1.2±0.1	0.5±0.3	0.3	0.3
A	3.2±0.2	1.6±0.2	1.6±0.2	1.2±0.1	0.8±0.3	0.7	0.8
B	3.5±0.2	2.8±0.2	1.9±0.2	2.2±0.1	0.8±0.3	0.7	1.1
C	6.0±0.3	3.2±0.3	2.5±0.3	2.2±0.1	1.3±0.3	1.0	2.5
D	7.3±0.3	4.3±0.3	2.8±0.3	2.4±0.1	1.3±0.3	1.0	3.8
E	7.3±0.3	4.3±0.3	4.0±0.3	2.4±0.1	1.3±0.3	1.0	3.8

5. Taping

5.1 tape dimension



Case size	A±0.2	B±0.2	C±0.1	E±0.1	F±0.1	W±0.3
S	1.6	2.4	4.0	1.75	3.5	8.0
A	1.9	3.5	4.0	1.75	3.5	8.0
B	3.3	3.9	4.0	1.75	3.5	8.0
C	3.7	6.4	8.0	1.75	5.5	12.0
D	4.8	7.7	8.0	1.75	5.5	12.0
E	4.8	7.7	8.0	1.75	5.5	12.0

case size	Qty.per reel
S	2500 pcs
A,B	2000 pcs
C,D	500 pcs
E	500 pcs

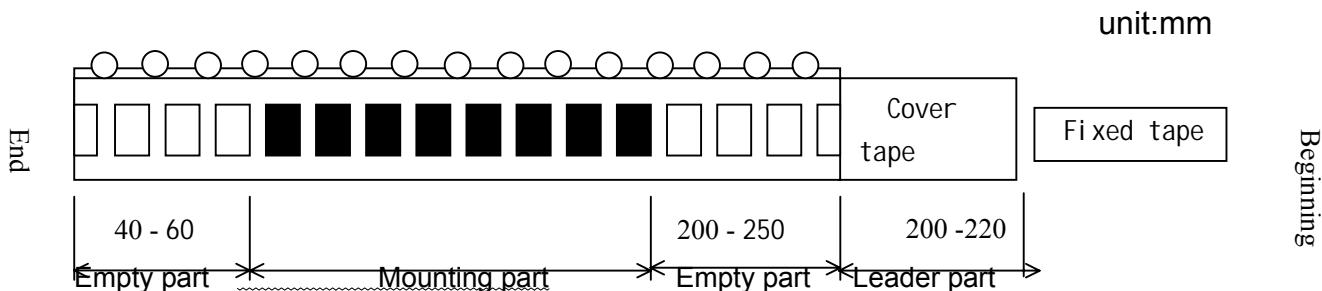
Solid Electrolytic Tantalum Chip Capacitor(Lead Free)

CA45 specification

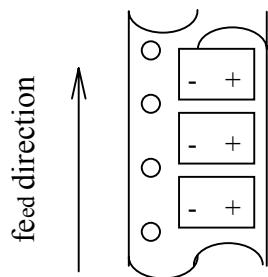
KOME

5.2 taping specification

1) taping specification



2) Polarity



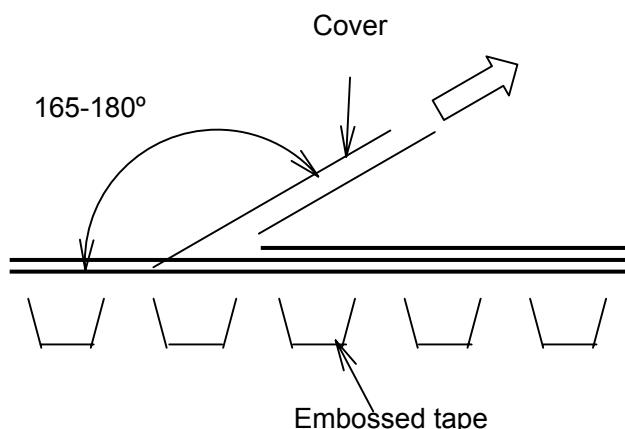
3) Peel method and force of the cover tape

Peel angle: 165-180 °

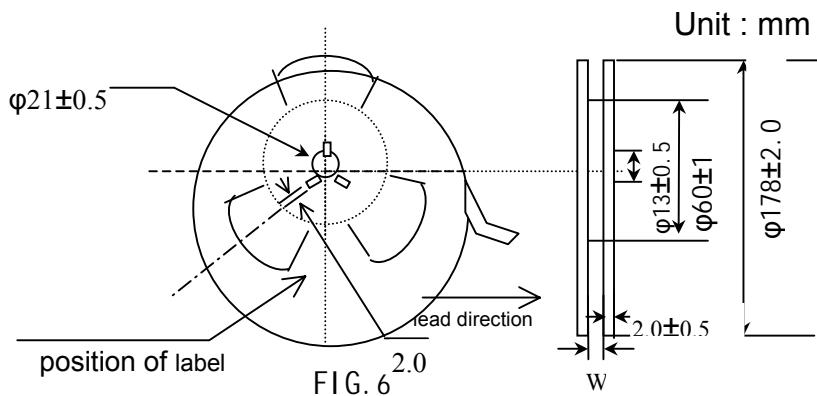
Peel speed: 300mm±10mm/min

Peel force: 0.1N - 1N(10-100g) for 8mm carrier tape

0.1N - 1.3N(10-130g) for 12mm carrier tape



6.Reel and Dimension



Case size	w(mm)
S,A,B	$8.4^{+1.50}_{-0.00}$
C,D,E	$12.4^{+2.00}_{-0.00}$

7. Electrical and Reliable Performance

NO.	Items	Performance characteristics								Conditions of test
1	operating temperature range	$-55 \sim +125^{\circ}\text{C}$								
2	rated temperature	$+85^{\circ}\text{C}$								
3	rated voltage(v)	4	6.3	10	16	20	25	35	50	
4	derated voltage(v)	2.5	4	6.3	10	13	16	23	33	$+125^{\circ}\text{C}$
5	surge voltage(v)	5	8	13	20	26	32	46	65	
6	leakage current	$0.01C_RV_R$ or $0.5 \mu\text{A}$ (whichever is greater)								Series protective resistor: 1000Ω Measuring voltage: rated voltage Measuring time: 1 minutes

Solid Electrolytic Tantalum Chip Capacitor(Lead Free)
CA45 specification

KOME

7	Capacitance	$\pm 20\%, \pm 10\%$	Measurement circuit: Equivalent series circuit Measuring frequency: $120\text{Hz} \pm 10\%$ Measuring voltage max.: $0.5\text{Vrms}, +1.5\text{Vdc}$.
8	Tangent of loss angle ($\tan\delta$)	$\leq 1.0\mu\text{F} : \leq 0.04$ $1.5 \sim 68\mu\text{F} : \leq 0.06$ $\geq 100\mu\text{F} : \leq 0.08$	
9	equivalent series resistance (ESR)	see table 1	

NO.	Items	Performance characteristics			Conditions of test
10	Characteristics at high and low temperature	Ste	Performance characteristics		Step temp.'C dur. 1 $+25 \pm 2$ - 2 -55 ± 2 30min. 3 $+25 \pm 2$ 30min. 4 $+85 \pm 2$ 30min. 5 $+125 \pm 2$ 30min 6 $+25 \pm 2$
		1	Change in cap.	Relative to the value item 7-10%	
			Tangent of loss angle ($\tan\delta$)	$U_R \geq 10\text{V} < 12\%$ $U_R < 10\text{V} < 15\%$	
		2	Change in cap.	Relative to the value item 7 $\pm 5\%$	
			Tangent of loss ($\tan\delta$)	Item 8max	
			leakage current	Item 6 max	
		3	Change in cap.	Relative to the value item 7 $+10\%$	
			Tangent of loss($\tan\delta$)	$UR \geq 10\text{V} < 12\%$ $UR < 10\text{V} < 15\%$	
			leakage current	max.0.1CV or 5 μA (whichever is greater)	
		4	Change in cap.	Relative to the value item 7 $+12\%$	
			Tangent of loss ($\tan\delta$)	$UR \geq 10\text{V}: < 15\%$ $UR < 10\text{V}: < 15\%$	
			leakage current	max.0.12CV or 6.0 μA (whichever is greater)	

Solid Electrolytic Tantalum Chip Capacitor(Lead Free)
CA45 specification

KOME

		5	Change in cap.	Relative to the value item 7 $\pm 5\%$		
			Tangent of loss($\tan\delta$)	Item 8 max		
			leakage current	Item 6 max		
11	Surge test	Change in cap.	Relative to the value before test $\pm 10\%$		test Temperature: $85 \pm 2^\circ\text{C}$ protective series resistor (charge resistor): 33Ω cycles: 1000 charge time: $30 \pm 5\text{s}$ discharge time: 5min.30s measuring voltage: surge voltage $85^\circ\text{C}: 1.3\text{UR}$	
			Tangent of loss($\tan\delta$)	Item 8 max		
		leakage current	Item 6 max			
		appearance	There shall be no such mechanical damage as terminal damage etc.			
12	Resistance to soldering heat	Change in cap.	Relative to the value before test $\pm 3\%$		Conditioning of solder dip: Solder temperature: $260 \pm 5^\circ\text{C}$ Dip duration: $5 \pm 0.5\text{s}$ depth of immersion: under surface 10mm	
			Tangent of loss($\tan\delta$)	Item 8 max		
		leakage current	Item 6 max			
		Appearance	no visible damage, The marking shall be legible.			
13	Solder ability	Solder wetting time shall be 3s or less, A new uniform coating of solder shall cover a minimum of 90% of the surface being immersed			Conditioning of solder dip Solder temperature: $235 \pm 5^\circ\text{C}$ Dip duration: $2 \pm 0.5\text{s}$ depth of immersion: under surface 10mm	

Solid Electrolytic Tantalum Chip Capacitor(Lead Free)
CA45 specification

KOME

14	rapid change of temperature	Change in cap.	Relative to the value before test ±5%	-55°C, 30 min., +125°C, 30min. as a cycle; 5 cycles
		Tangent of loss($\tan\delta$)	Item 8 max	
		leakage current	Item 6 max	
		Appearance	No visible damage	
15	Damp heat	Change in cap.	Relative to the value before test ±10%	Test temp: 40±2°C Humidity: 90-95% R.H Test time: 56 days No voltage applied Recovery: 1-2 hours
		Tangent of loss($\tan\delta$)	less than 1.2 times of item 8	
		leakage current	Item 6 max	
		Appearance	no visible damage, The marking shall be legible.	
16	Electrical endurance	Change in cap.	Relative to the value before test ±10%	1) Test temp: 85°C±2°C Test time: 2000 hr Voltage: Rated voltage 2) Test temp: 125°C±2°C Test time: 2000 h Voltage: Derated voltage Recovery: 1-2 h D.V.- Derated voltage R.V.- Rated voltage
		Tangent of loss($\tan\delta$)	less than 1.5 times of item 8	
		leakage current	6 max×200%(max.)	
		Appearance	no visible damage, The marking shall be legible.	

Solid Electrolytic Tantalum Chip Capacitor(Lead Free)
CA45 specification

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Table 1: ESR Of Capacitor

unit: Ω

Rated voltage	4	6.3	10	16	20	25	35	50
Capacitance	Maximum ESR at 100KHz (Standard/Extended case size)							
0.1					25		24	22
0.15					25		21	17/15
0.22					25		18	14
0.33					25		15	12
0.47				25	25	14	10/12	8
0.68			30	25	12/25	10	8/10	7
1.0		14/25	13/25	11/20	9	7/8	6.5/10	5.5
1.5	30	12/25	10/10	8/12	5/6.5	5	4.5/5.2	4/4.5
2.2	25	9/20	7/15	5.5/6.5	3.5/5.3	4.5	3.5/4.0	2.5/3.5
3.3	9/20	7/12	5.0/5.5	5/6.0	2.5/3/7	2.8/4.0	2.0/2.5/3.5	2.0
4.7	7.5/10	5/6	4/5/10	3.5/4	2.5/3.0/6.0	2.4/3.5	1.5/2.2	1.4/1.5
6.8	6/6.5	4/5/15	3/4	2.5/3.5/5	1.8/2/3.5	1.4/2	1.3/2.0	0.9
10	4/6	3/4/10	2.5/3	2/2.8/5	1.3/1.8/3.0	1.2/1.8	1/1.2	0.8
15	3.5/4	2.5/3.2	2.2/2.8/6	1.8/3.0	1.1/1.7	1/1.2	0.9	
22	2.5/3.2	2/2.5	1.8/2.4	1.1/16	0.9/1.2	0.9	0.9	
33	2.2/2.8	1.3/1.8	1.1/1.6	0.9/1.5	0.9	0.9/0.7		
47	1.3/1.8	1.6/2	0.9/1.2/1	0.9/1.4	0.9/0.9	0.6		
68	1.1/1.6/2.5	0.9/1.6/1	0.9	0.9	0.9/0.7			
100	0.9/1.3/2.5	0.9/1.4	0.9/1.3	0.9	0.5			
150	0.9	0.9	0.9	0.9				
220	0.9/1.2	0.9/0.7	0.9 /0.5	0.9				
330	0.9	0.9/0.7	0.9					
470	0.9							

8. Note in use

8.1 For circuits with low resistance circuit ,make the use voltage be 1/3 or under of the rated voltage, in general circuit, make the use voltage be 1/2 or under of the rated voltage.

8.2 In case of circuits with large instantaneous rush current or rapid charging/discharging circuits, connect the protection resistor of $3\Omega/v$ or more in series to the capacitor to limit the current to 300mA or less. when the protection resistor can not be inserted, lower the use voltage to 1/3 or under of the rated voltage .

8.3 Use the capacitors within the permissible ripple voltage specified independently. Use in the range that the sum of the DC voltage value and the peak value of ripple voltage does not exceed the rated voltage. Design not to apply over voltage made by fluctuation of superimposed DC voltage or reverse voltage to the capacitors.

8.4 Use the capacitors within the specified use temperature range. In case use temperature exceeds +85'C,apply the reduced voltage shown in the below figure as the rated voltage.

8.5 environmental conditions

do not use the equipment fit with the capacitor in the below environment.

- Environment where capacitors are directly splashed with water, salt water and oil.
- Environment where capacitors are directly exposed to sunlight.
- Environment in high temperature and humidity causing dewing on capacitor surface.
- Environment where capacitors touch various active gases.
- Acid and alkaline atmosphere.
- Environment with high frequency induction.
- Environment with excessive vibration and shock.

Solid Electrolytic Tantalum Chip Capacitor(Lead Free)
CA45 specification KOME

9. Product size table

Rated voltage (V)	4	6.3	10	16	20	25	35	50
Capacitance(uf)	Case size(Standard/Extended)							
0.1					S	S	A/S	A
0.15					S	S	A	B/A
0.22					S		A	B
0.33					S		A	B
0.47				S	S	A	B/A	C/B
0.68			S	S	A/S	A	B/A	C/B
1.0		A/S	A/S	A/S	A/S	B/A	B/A	D/C/B
1.5	S	A/S	A/S	A/S	B/A	B/A	C/B/A	D/C
2.2	S	A/S	A/S	B/A	B/A	B/A	C/B	D/C
3.3	A/S	A/S	A/S	B/A	C/B/A	C/B/A	D/C/B	D
4.7	A/S	A/S	B/A/S	B/A	D/C/B/A	C/B	D/C	E/D
6.8	A/S	B/A/S	B/A/S	C/B/A	D/C/B	D/C/B	D/C	E
10	B/A/S	B/A/S	B/A	C/B/A	D/C/B	D/C/B	D/C	E
15	B/A	B/A	C/B/A	C/B	D/C	D/C	D	
22	B/A	B/A	C/B/A	D/C/B	D/C	D/C	E/D	
33	C/B	C/B	D/C/B	D/C	D	E/D		
47	C/B	C/B	D/C/B	D/C	E/D	E/D		
68	D/C/B	D/C/B	D/C	D	E/D			
100	D/C/B	D/C/B	D/C	D	E			
150	D/C	D/C	E/D	E/D				
220	D/C	E/D/C	E/D					
330	E/D	E/D						
470	E/D	E/D						

10. Storage

10.1 storage condition

environmental temperature:-10'C ~+40'C;

relative humidity: no more than 70%;

10.2 storing period

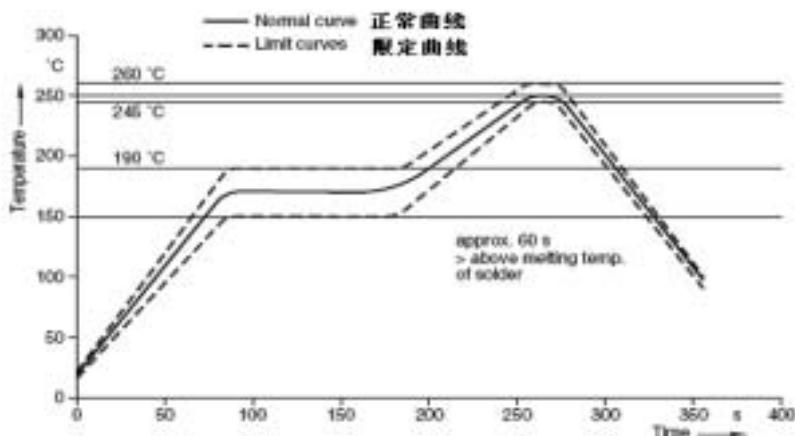
No more than one and half year since date of stocking.

11. Recommended Soldering condition

Flow method or reflow method whichever is applied for chip type capacitors, high-activated flux with strong acid will not be used to prevent permeation, corrosion and diffusion from incomplete cleaning, thereby resulting in decreasing reliability.

chip type capacitors can be applied to reflow method. take the conditions below shown:

Reflow method(Atmosphere heating method)



- If the land is excessively larger than the size of the terminal surface, dislocation may occur when solder melts.

12. Information about ODS and PBBS and PBBOS

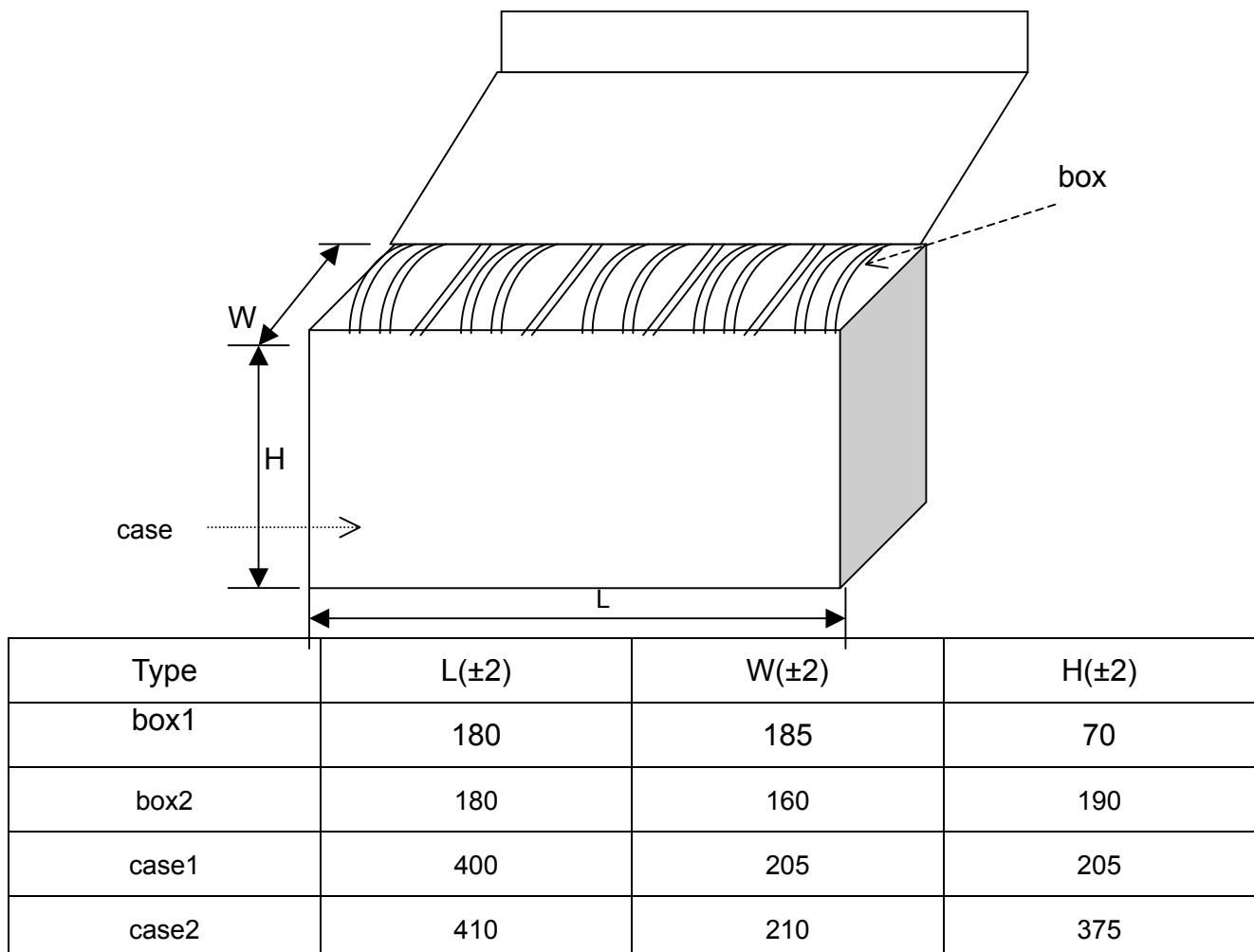
1. If exist Ozone Depleting Substances (ODS): no CCL₄,HCFC,etc.
2. If exist nonflammable material such as Poly brominated Biphenyls and Poly brominated Biphenyl Oxides (PBBS and PBBOS): no PBBS and PBBOS,etc.
3. If exist heavy metal: yes(lead and its compounds: $\leq 0.15\%$ / pcs.,)

13. Product change notification

Our company will notice the customers ahead of time, when the product was changed in specification, material, process and management system.

14. Packaging figure of product

Box and case dimensions (unit :mm)



a.5 reels of S/A/B or 4 reels of C/D/E in a box1.

b.10 reels of C/D/E in a box2.

c.5 boxes1 or 2 boxes2 in a case1.

d.10 boxes1 or 4 boxes2 in a case2.